

## Maximum Ratings (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Drain-Source Voltage		$V_{DSS}$	-20	V
Gate-Source Voltage		$V_{GSS}$	±12	V
Drain Current (Note 5) Continuous	T <sub>A</sub> = +25°C T <sub>A</sub> = +70°C	l <sub>D</sub>	-3.0 -2.4	А
Pulsed Drain Current (Note 6)		I <sub>DM</sub>	-15	Α
Body-Diode Continuous Current (Note 5)		Is	2.0	Α

### **Thermal Characteristics**

Characteristic	Symbol	Value	Unit
Total Power Dissipation (Note 5)	$P_{D}$	1.4	W
Thermal Resistance, Junction to Ambient (Note 5); Steady-State	$R_{ heta JA}$	90	°C/W
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C

Notes:

- 5. Device mounted on 1"x1", FR-4 PC board with 2 oz. Copper and test pulse width t  $\leq$ 10s. 6. Repetitive Rating, pulse width limited by junction temperature.

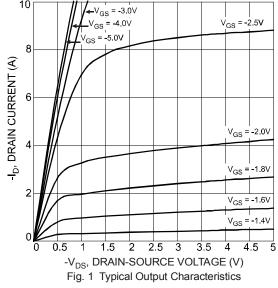
### Electrical Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

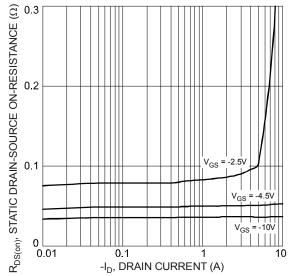
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
STATIC PARAMETERS							
Drain-Source Breakdown Voltage	$BV_{DSS}$	-20	_	_	V	$I_D = -250 \mu A, V_{GS} = 0 V$	
Zero Gate Voltage Drain Current $T_J = +25^{\circ}C$	I <sub>DSS</sub>	_		-1	μΑ	$V_{DS} = -20V$ , $V_{GS} = 0V$	
Gate-Body Leakage Current	I <sub>GSS</sub>	_		±100	nA	$V_{DS} = 0V, V_{GS} = \pm 12V$	
Gate Threshold Voltage	V <sub>GS(th)</sub>	-0.6		-1.25	V	$V_{DS} = V_{GS}, I_D = -250\mu A$	
On State Drain Current (Note 7)	I <sub>D (ON)</sub>	-15	_		Α	$V_{GS} = -4.5V, V_{DS} = -5V$	
	R <sub>DS(ON)</sub>	_	51	72	mΩ	$V_{GS} = -4.5V$ , $I_D = -3.5A$	
Static Drain-Source On-Resistance (Note 7)			87	108		$V_{GS} = -2.7V, I_D = -3.0A$	
			99	123		$V_{GS} = -2.5V, I_D = -2.6A$	
Forward Transconductance (Note 7)	<b>g</b> FS	_	7.3	_	S	$V_{DS} = -10V, I_D = -3.0A$	
Diode Forward Voltage (Note 5)	$V_{SD}$	_	0.79	-1.26	V	I <sub>S</sub> = -1.7A, V <sub>GS</sub> = 0V	
Maximum Body-Diode Continuous Current (Note 5)	Is	_	_	1.7	Α	_	
DYNAMIC PARAMETERS (Note 8)							
Total Gate Charge	$Q_g$	_	7.3		nC	$V_{GS} = -4.5V$ , $V_{DS} = -10V$ , $I_D = -3.0A$	
Gate-Source Charge	Qgs	_	2.0		nC	$V_{GS}$ = -4.5V, $V_{DS}$ = -10V, $I_D$ = -3.0A	
Gate-Drain Charge	$Q_{gd}$	_	1.9		nC	$V_{GS} = -4.5V$ , $V_{DS} = -10V$ , $I_D = -3.0A$	
Turn-On Delay Time	t <sub>D(on)</sub>	_	12	_	ns		
Turn-On Rise Time	t <sub>r</sub>	_	20	_	ns	$V_{DS} = -10V, V_{GS} = -4.5V,$	
Turn-Off Delay Time	t <sub>D(off)</sub>	_	38		ns	$R_L = 10\Omega$ , $R_G = 6\Omega$	
Turn-Off Fall Time	t <sub>f</sub>	_	41		ns		
Input Capacitance	C <sub>iss</sub>	_	443	_	pF	V <sub>DS</sub> = -16V, V <sub>GS</sub> = 0V -f = 1.0MHz	
Output Capacitance	Coss	_	128	_	pF		
Reverse Transfer Capacitance	Crss	_	101	_	pF		

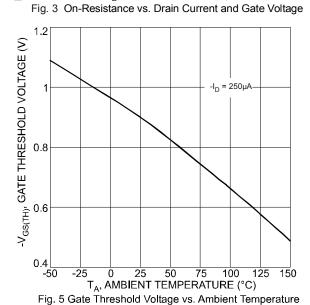
Notes: 7. Test pulse width  $t = 300 \mu s$ .

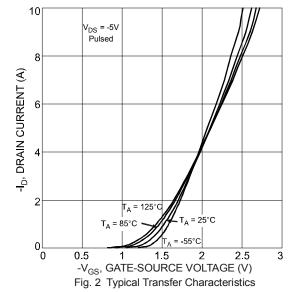
8. Guaranteed by design. Not subject to production testing.

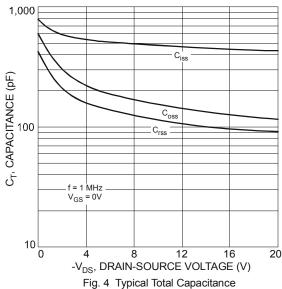












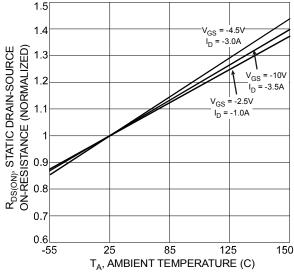


Fig. 6 Normalized Static Drain-Source On-Resistance vs. Ambient Temperature



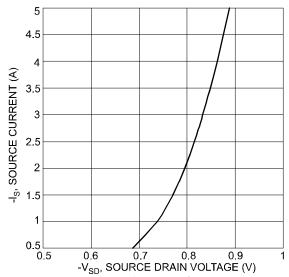
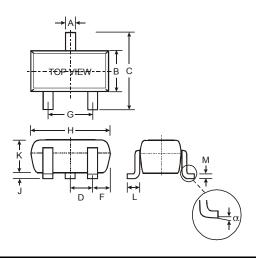


Fig. 7 Reverse Drain Current vs. Source-Drain Voltage

# **Package Outline Dimensions**

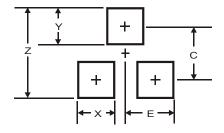
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



SOT23				
Dim	Min	Max		
Α	0.37	0.51		
В	1.20	1.40		
С	2.30	2.50		
D	0.89	1.03		
F	0.45	0.60		
G	1.78	2.05		
Н	2.80	3.00		
J	0.013	0.10		
K	0.903	1.10		
L	0.45	0.61		
М	0.085	0.180		
α	0°	8°		
All Dimensions in mm				

# **Suggested Pad Layout**

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for latest version.



Dimensions	Value (in mm)
Z	2.9
Х	8.0
Υ	0.9
С	2.0
E	1.35



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